Lattice Semiconductor Corporation - LC4064ZE-7MN64C Datasheet

Welcome to E-XFL.COM

Understanding Embedded - CPLDs (Complex Programmable Logic Devices)

Embedded - CPLDs, or Complex Programmable Logic Devices, are highly versatile digital logic devices used in electronic systems. These programmable components are designed to perform complex logical operations and can be customized for specific applications. Unlike fixed-function ICs, CPLDs offer the flexibility to reprogram their configuration, making them an ideal choice for various embedded systems. They consist of a set of logic gates and programmable interconnects, allowing designers to implement complex logic circuits without needing custom hardware.

Applications of Embedded - CPLDs

Details	
Product Status	Active
Programmable Type	In System Programmable
Delay Time tpd(1) Max	7.5 ns
Voltage Supply - Internal	1.7V ~ 1.9V
Number of Logic Elements/Blocks	4
Number of Macrocells	64
Number of Gates	-
Number of I/O	48
Operating Temperature	0°C ~ 90°C (TJ)
Mounting Type	Surface Mount
Package / Case	64-TFBGA, CSPBGA
Supplier Device Package	64-CSBGA (5x5)
Purchase URL	https://www.e-xfl.com/product-detail/lattice-semiconductor/lc4064ze-7mn64c

Introduction

The high performance ispMACH 4000ZE family from Lattice offers an ultra low power CPLD solution. The new family is based on Lattice's industry-leading ispMACH 4000 architecture. Retaining the best of the previous generation, the ispMACH 4000ZE architecture focuses on significant innovations to combine high performance with low power in a flexible CPLD family. For example, the family's new Power Guard feature minimizes dynamic power consumption by preventing internal logic toggling due to unnecessary I/O pin activity.

The ispMACH 4000ZE combines high speed and low power with the flexibility needed for ease of design. With its robust Global Routing Pool and Output Routing Pool, this family delivers excellent First-Time-Fit, timing predictability, routing, pin-out retention and density migration.

The ispMACH 4000ZE family offers densities ranging from 32 to 256 macrocells. There are multiple density-I/O combinations in Thin Quad Flat Pack (TQFP), Chip Scale BGA (csBGA), and Ultra Chip Scale BGA (ucBGA) packages ranging from 32 to 144 pins/balls. Table 1 shows the macrocell, package and I/O options, along with other key parameters.

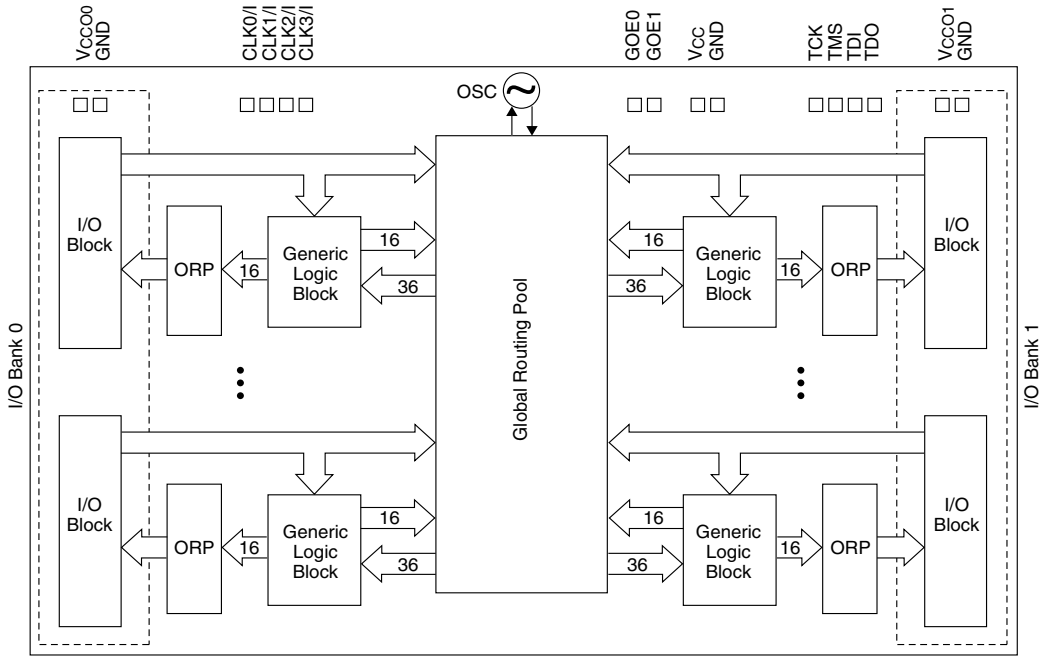
A user programmable internal oscillator and a timer are included in the device for tasks like LED control, keyboard scanner and similar housekeeping type state machines. This feature can be optionally disabled to save power.

The ispMACH 4000ZE family has enhanced system integration capabilities. It supports a 1.8V supply voltage and 3.3V, 2.5V, 1.8V and 1.5V interface voltages. Additionally, inputs can be safely driven up to 5.5V when an I/O bank is configured for 3.3V operation, making this family 5V tolerant. The ispMACH 4000ZE also offers enhanced I/O features such as slew rate control, PCI compatibility, bus-keeper latches, pull-up resistors, pull-down resistors, open drain outputs and hot socketing. Pull-up, pull-down and bus-keeper features are controllable on a "per-pin" basis. The ispMACH 4000ZE family members are 1.8V in-system programmable through the IEEE Standard 1532 interface. IEEE Standard 1149.1 boundary scan testing capability also allows product testing on automated test equipment. The 1532 interface signals TCK, TMS, TDI and TDO are referenced to V_{CC} (logic core).

Overview

The ispMACH 4000ZE devices consist of multiple 36-input, 16-macrocell Generic Logic Blocks (GLBs) interconnected by a Global Routing Pool (GRP). Output Routing Pools (ORPs) connect the GLBs to the I/O Blocks (IOBs), which contain multiple I/O cells. This architecture is shown in Figure 1.

Figure 1. Functional Block Diagram



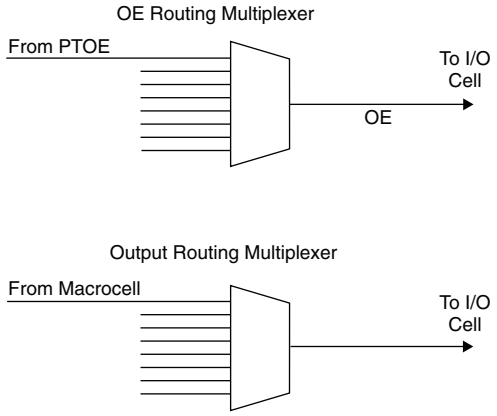
Output Routing Pool (ORP)

The Output Routing Pool allows macrocell outputs to be connected to any of several I/O cells within an I/O block. This provides greater flexibility in determining the pinout and allows design changes to occur without affecting the pinout. The output routing pool also provides a parallel capability for routing macrocell-level OE product terms. This allows the OE product term to follow the macrocell output as it is switched between I/O cells. The enhanced ORP of the ispMACH 4000ZE family consists of the following elements:

- Output Routing Multiplexers
- OE Routing Multiplexers

Figure 7 shows the structure of the ORP from the I/O cell perspective. This is referred to as an ORP slice. Each ORP has as many ORP slices as there are I/O cells in the corresponding I/O block.

Figure 7. ORP Slice



Output Routing Multiplexers

The details of connections between the macrocells and the I/O cells vary across devices and within a device dependent on the maximum number of I/Os available. Tables 5-7 provide the connection details.

Table 5. GLB/MC/ORP Combinations for ispMACH 4256ZE

GLB/MC	ORP Mux Input Macrocells
[GLB] [MC 0]	M0, M1, M2, M3, M4, M5, M6, M7
[GLB] [MC 1]	M2, M3, M4, M5, M6, M7, M8, M9
[GLB] [MC 2]	M4, M5, M6, M7, M8, M9, M10, M11
[GLB] [MC 3]	M6, M7, M8, M9, M10, M11, M12, M13
[GLB] [MC 4]	M8, M9, M10, M11, M12, M13, M14, M15
[GLB] [MC 5]	M10, M11, M12, M13, M14, M15, M0, M1
[GLB] [MC 6]	M12, M13, M14, M15, M0, M1, M2, M3
[GLB] [MC 7]	M14, M15, M0, M1, M2, M3, M4, M5

Table 6. GLB/MC/ORP Combinations for ispMACH 4128ZE

GLB/MC	ORP Mux Input Macrocells
[GLB] [MC 0]	M0, M1, M2, M3, M4, M5, M6, M7
[GLB] [MC 1]	M1, M2, M3, M4, M5, M6, M7, M8
[GLB] [MC 2]	M2, M3, M4, M5, M6, M7, M8, M9
[GLB] [MC 3]	M4, M5, M6, M7, M8, M9, M10, M11
[GLB] [MC 4]	M5, M6, M7, M8, M9, M10, M11, M12
[GLB] [MC 5]	M6, M7, M8, M9, M10, M11, M12, M13
[GLB] [MC 6]	M8, M9, M10, M11, M12, M13, M14, M15
[GLB] [MC 7]	M9, M10, M11, M12, M13, M14, M15, M0
[GLB] [MC 8]	M10, M11, M12, M13, M14, M15, M0, M1
[GLB] [MC 9]	M12, M13, M14, M15, M0, M1, M2, M3
[GLB] [MC 10]	M13, M14, M15, M0, M1, M2, M3, M4
[GLB] [MC 11]	M14, M15, M0, M1, M2, M3, M4, M5

Table 7. GLB/MC/ORP Combinations for ispMACH 4032ZE and 4064ZE

GLB/MC	ORP Mux Input Macrocells
[GLB] [MC 0]	M0, M1, M2, M3, M4, M5, M6, M7
[GLB] [MC 1]	M1, M2, M3, M4, M5, M6, M7, M8
[GLB] [MC 2]	M2, M3, M4, M5, M6, M7, M8, M9
[GLB] [MC 3]	M3, M4, M5, M6, M7, M8, M9, M10
[GLB] [MC 4]	M4, M5, M6, M7, M8, M9, M10, M11
[GLB] [MC 5]	M5, M6, M7, M8, M9, M10, M11, M12
[GLB] [MC 6]	M6, M7, M8, M9, M10, M11, M12, M13
[GLB] [MC 7]	M7, M8, M9, M10, M11, M12, M13, M14
[GLB] [MC 8]	M8, M9, M10, M11, M12, M13, M14, M15
[GLB] [MC 9]	M9, M10, M11, M12, M13, M14, M15, M0
[GLB] [MC 10]	M10, M11, M12, M13, M14, M15, M0, M1
[GLB] [MC 11]	M11, M12, M13, M14, M15, M0, M1, M2
[GLB] [MC 12]	M12, M13, M14, M15, M0, M1, M2, M3
[GLB] [MC 13]	M13, M14, M15, M0, M1, M2, M3, M4
[GLB] [MC 14]	M14, M15, M0, M1, M2, M3, M4, M5
[GLB] [MC 15]	M15, M0, M1, M2, M3, M4, M5, M6

Output Enable Routing Multiplexers

The OE Routing Pool provides the corresponding local output enable (OE) product term to the I/O cell.

I/O Cell

The I/O cell contains the following programmable elements: output buffer, input buffer, OE multiplexer, Power Guard and bus maintenance circuitry. Figure 8 details the I/O cell.

The block-level OE PT of each GLB is also tied to Block Input Enable (BIE) of that block. Hence, for a 256-macrocell device (with 16 blocks), each block's BIE signal is driven by block-level OE PT from each block.

Figure 11. Global OE Generation for All Devices Except ispMACH 4032ZE

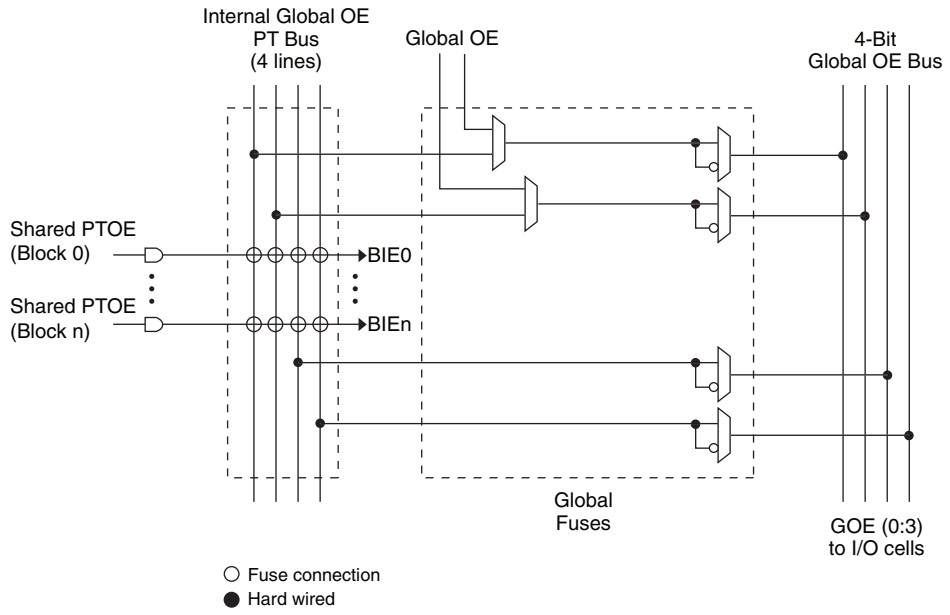
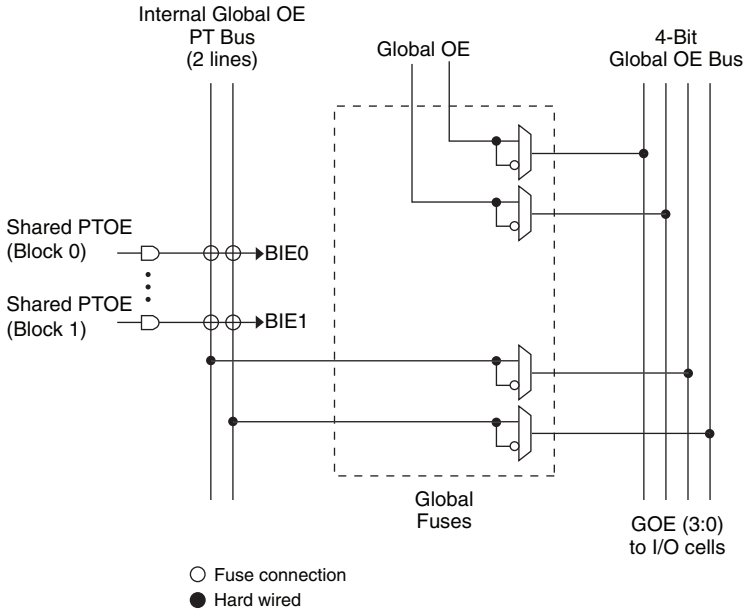


Figure 12. Global OE Generation for ispMACH 4032ZE



On-Chip Oscillator and Timer

An internal oscillator is provided for use in miscellaneous housekeeping functions such as watchdog heartbeats, digital de-glitch circuits and control state machines. The oscillator is disabled by default to save power. Figure 13 shows the block diagram of the oscillator and timer block.

Figure 13. On-Chip Oscillator and Timer

Table 11. On-Chip Oscillator and Timer Signal Names

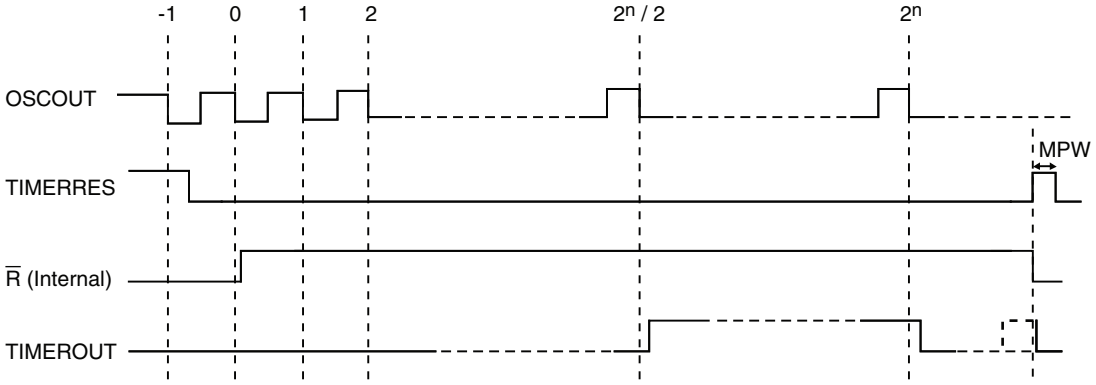
Signal Name	Input or Output	Optional / Required	Description
OSCOUT	Output	Optional	Oscillator Output (Nominal Frequency: 5MHz)
TIMEROUT	Output	Optional	Oscillator Frequency Divided by an integer TIMER_DIV (Default 128)
TIMERRES	Input	Optional	Reset the Timer
DYNOSCDIS	Input	Optional	Disables the Oscillator, resets the Timer and saves the power.

OSCTIMER has two outputs, OSCOUT and TIMEROUT. The outputs feed into the Global Routing Pool (GRP). From GRP, these signals can drive any macrocell input, as well as any output pin (with macrocell bypass). The output OSCOUT is the direct oscillator output with a typical frequency of 5MHz, whereas, the output TIMEROUT is the oscillator output divided by an attribute TIMER_DIV.

The attribute TIMER_DIV can be: 128 (7 bits), 1024 (10 bits) or 1,048,576 (20 bits). The divided output is provided for those user situations, where a very slow clock is desired. If even a slower toggling clock is desired, then the programmable macrocell resources can be used to further divide down the TIMEROUT output.

Figure 14 shows the simplified relationship among OSCOUT, TIMERRES and TIMEROUT. In the diagram, the signal "$\overline{R}$" is an internal reset signal that is used to synchronize TIMERRES to OSCOUT. This adds one extra clock cycle delay for the first timer transition after TIMERRES.

Figure 14. Relationship Among OSCOUT, TIMERRES and TIMEROUT



Note: n = Number of bits in the divider (7, 10 or 20)
Metastability: If the signal TIMERRES is not synchronous to OSCOUT, it could make a difference of one or two clock cycles to the TIMEROUT going high the first time.

I/O Recommended Operating Conditions

Standard	V_{CCO} (V)[1]	
	Min.	Max.
LVTTL	3.0	3.6
LVCMOS 3.3	3.0	3.6
Extended LVCMOS 3.3	2.7	3.6
LVCMOS 2.5	2.3	2.7
LVCMOS 1.8	1.65	1.95
LVCMOS 1.5	1.4	1.6
PCI 3.3	3.0	3.6

1. Typical values for V_{CCO} are the average of the min. and max. values.

DC Electrical Characteristics

Over Recommended Operating Conditions

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
I_{IL}, I_{IH}[1, 2]	Input Leakage Current	$0 \le V_{IN} < V_{CCO}$	—	0.5	1	µA
I_{IH}[1]	Input High Leakage Current	$V_{CCO} < V_{IN} \le 5.5V$	—	—	10	µA
I_{PU}	I/O Weak Pull-up Resistor Current	$0 \le V_{IN} \le 0.7V_{CCO}$	-20	—	-150	µA
I_{PD}	I/O Weak Pull-down Resistor Current	V_{IL} (MAX) $\le V_{IN} \le V_{IH}$ (MAX)	30	—	150	µA
I_{BHLS}	Bus Hold Low Sustaining Current	$V_{IN} = V_{IL}$ (MAX)	30	—	—	µA
I_{BHHS}	Bus Hold High Sustaining Current	$V_{IN} = 0.7\ V_{CCO}$	-20	—	—	µA
I_{BHLO}	Bus Hold Low Overdrive Current	$0V \le V_{IN} \le V_{BHT}$	—	—	150	µA
I_{BHHO}	Bus Hold High Overdrive Current	$V_{BHT} \le V_{IN} \le V_{CCO}$	—	—	-150	µA
V_{BHT}	Bus Hold Trip Points	—	V_{CCO} * 0.35	—	V_{CCO} * 0.65	V
C_1	I/O Capacitance[3]	V_{CCO} = 3.3V, 2.5V, 1.8V, 1.5V	—	8	—	pf
		V_{CC} = 1.8V, V_{IO} = 0 to V_{IH} (MAX)	—		—	
C_2	Clock Capacitance[3]	V_{CCO} = 3.3V, 2.5V, 1.8V, 1.5V	—	6	—	pf
		V_{CC} = 1.8V, V_{IO} = 0 to V_{IH} (MAX)	—		—	
C_3	Global Input Capacitance[3]	V_{CCO} = 3.3V, 2.5V, 1.8V, 1.5V	—	6	—	pf
		V_{CC} = 1.8V, V_{IO} = 0 to V_{IH} (MAX)	—		—	

1. Input or I/O leakage current is measured with the pin configured as an input or as an I/O with the output driver tristated. It is not measured with the output driver active. Bus maintenance circuits are disabled.
2. I_{IH} excursions of up to 1.5µA maximum per pin above the spec limit may be observed for certain voltage conditions on no more than 10% of the device's I/O pins.
3. Measured T_A = 25°C, f = 1.0MHz.

ispMACH 4000ZE Internal Timing Parameters (Cont.)

Over Recommended Operating Conditions

Parameter	Description		LC4032ZE -4 Min.	LC4032ZE -4 Max.	LC4064ZE -4 Min.	LC4064ZE -4 Max.	Units
LVCMOS15_out	Output Configured as 1.5V Buffer	t_{EN}, t_{DIS}, t_{BUF}	—	0.20	—	0.20	ns
LVCMOS18_out	Output Configured as 1.8V Buffer	t_{EN}, t_{DIS}, t_{BUF}	—	0.00	—	0.00	ns
LVCMOS25_out	Output Configured as 2.5V Buffer	t_{EN}, t_{DIS}, t_{BUF}	—	0.10	—	0.10	ns
LVCMOS33_out	Output Configured as 3.3V Buffer	t_{EN}, t_{DIS}, t_{BUF}	—	0.20	—	0.20	ns
PCI_out	Output Configured as PCI Compatible Buffer	t_{EN}, t_{DIS}, t_{BUF}	—	0.20	—	0.20	ns
Slow Slew	Output Configured for Slow Slew Rate	t_{EN}, t_{BUF}	—	1.00	—	1.00	ns

Note: Internal Timing Parameters are not tested and are for reference only. Refer to the timing model in this data sheet for further details.
Timing v.0.8

ispMACH 4000ZE Internal Timing Parameters (Cont.)

Over Recommended Operating Conditions

Parameter	Description		All Devices				Units
			-5		-7		
			Min.	Max.	Min.	Max.	
t_{SRR}	Asynchronous Reset or Set Recovery Delay		—	1.80	—	1.67	ns
Control Delays							
t_{BCLK}	GLB PT Clock Delay		—	1.45	—	0.95	ns
t_{PTCLK}	Macrocell PT Clock Delay		—	1.45	—	1.15	ns
t_{BSR}	Block PT Set/Reset Delay		—	1.85	—	1.83	ns
t_{PTSR}	Macrocell PT Set/Reset Delay		—	1.85	—	2.72	ns
t_{BIE}	Power Guard Block Input Enable Delay		—	1.75	—	1.95	ns
t_{PTOE}	Macrocell PT OE Delay		—	2.40	—	1.90	ns
t_{GPTOE}	Global PT OE Delay		—	4.20	—	3.40	ns
Internal Oscillator							
t_{OSCSU}	Oscillator DYNOSCDIS Setup Time		5.00	—	5.00	—	ns
t_{OSCH}	Oscillator DYNOSCDIS Hold Time		5.00	—	5.00	—	ns
t_{OSCEN}	Oscillator OSCOUT Enable Time (To Stable)		—	5.00	—	5.00	ns
t_{OSCOD}	Oscillator Output Delay		—	4.00	—	4.00	ns
t_{OSCNOM}	Oscillator OSCOUT Nominal Frequency			5.00		5.00	MHz
t_{OSCvar}	Oscillator Variation of Nominal Frequency		—	30	—	30	%
$t_{TMRCO20}$	Oscillator TIMEROUT Clock (Negative Edge) to Out (20-Bit Divider)		—	12.50	—	14.50	ns
$t_{TMRCO10}$	Oscillator TIMEROUT Clock (Negative Edge) to Out (10-Bit Divider)		—	7.50	—	9.50	ns
t_{TMRCO7}	Oscillator TIMEROUT Clock (Negative Edge) to Out (7-Bit Divider)		—	6.00	—	8.00	ns
$t_{TMRRSTO}$	Oscillator TIMEROUT Reset to Out (Going Low)		—	5.00	—	7.00	ns
t_{TMRRR}	Oscillator TIMEROUT Asynchronous Reset Recovery Delay		—	4.00	—	6.00	ns
$t_{TMRRSTPW}$	Oscillator TIMEROUT Reset Minimum Pulse Width		3.00	—	5.00	—	ns
Optional Delay Adjusters		**Base Parameter**					
t_{INDIO}	Input Register Delay	t_{INREG}	—	1.60	—	2.60	ns
t_{EXP}	Product Term Expander Delay	t_{MCELL}	—	0.45	—	0.50	ns
t_{BLA}	Additional Block Loading Adders	t_{ROUTE}	—	0.05	—	0.05	ns
t_{IOI} Input Buffer Delays							
LVTTL_in	Using LVTTL Standard with Hysteresis	t_{IN}, t_{GCLK_IN}, t_{GOE}	—	0.60	—	0.60	ns
LVCMOS15_in	Using LVCMOS 1.5 Standard	t_{IN}, t_{GCLK_IN}, t_{GOE}	—	0.20	—	0.20	ns
LVCMOS18_in	Using LVCMOS 1.8 Standard	t_{IN}, t_{GCLK_IN}, t_{GOE}	—	0.00	—	0.00	ns
LVCMOS25_in	Using LVCMOS 2.5 Standard with Hysteresis	t_{IN}, t_{GCLK_IN}, t_{GOE}	—	0.80	—	0.80	ns
LVCMOS33_in	Using LVCMOS 3.3 Standard with Hysteresis	t_{IN}, t_{GCLK_IN}, t_{GOE}	—	0.80	—	0.80	ns
PCI_in	Using PCI Compatible Input with Hysteresis	t_{IN}, t_{GCLK_IN}, t_{GOE}	—	0.80	—	0.80	ns
t_{IOO} Output Buffer Delays							
LVTTL_out	Output Configured as TTL Buffer	t_{EN}, t_{DIS}, t_{BUF}	—	0.20	—	0.20	ns

Boundary Scan Waveforms and Timing Specifications

Symbol	Parameter	Min.	Max.	Units
t_{BTCP}	TCK [BSCAN test] clock cycle	40	—	ns
t_{BTCH}	TCK [BSCAN test] pulse width high	20	—	ns
t_{BTCL}	TCK [BSCAN test] pulse width low	20	—	ns
t_{BTSU}	TCK [BSCAN test] setup time	8	—	ns
t_{BTH}	TCK [BSCAN test] hold time	10	—	ns
t_{BRF}	TCK [BSCAN test] rise and fall time	50	—	mV/ns
t_{BTCO}	TAP controller falling edge of clock to valid output	—	10	ns
t_{BTOZ}	TAP controller falling edge of clock to data output disable	—	10	ns
t_{BTVO}	TAP controller falling edge of clock to data output enable	—	10	ns
t_{BTCPSU}	BSCAN test Capture register setup time	8	—	ns
t_{BTCPH}	BSCAN test Capture register hold time	10	—	ns
t_{BTUCO}	BSCAN test Update reg, falling edge of clock to valid output	—	25	ns
t_{BTUOZ}	BSCAN test Update reg, falling edge of clock to output disable	—	25	ns
t_{BTUOV}	BSCAN test Update reg, falling edge of clock to output enable	—	25	ns

Switching Test Conditions

Figure 17 shows the output test load that is used for AC testing. The specific values for resistance, capacitance, voltage, and other test conditions are shown in Table 13.

Figure 17. Output Test Load, LVTTL and LVCMOS Standards

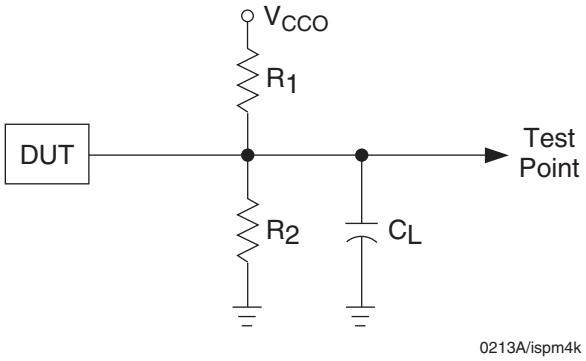


Table 13. Test Fixture Required Components

Test Condition	R_1	R_2	C_L[1]	Timing Ref.	V_{CCO}
LVCMOS I/O, (L -> H, H -> L)	106Ω	106Ω	35pF	LVCMOS 3.3 = 1.5V	LVCMOS 3.3 = 3.0V
				LVCMOS 2.5 = $\frac{V_{CCO}}{2}$	LVCMOS 2.5 = 2.3V
				LVCMOS 1.8 = $\frac{V_{CCO}}{2}$	LVCMOS 1.8 = 1.65V
				LVCMOS 1.5 = $\frac{V_{CCO}}{2}$	LVCMOS 1.5 = 1.4V
LVCMOS I/O (Z -> H)	∞	106Ω	35pF	1.5V	3.0V
LVCMOS I/O (Z -> L)	106Ω	∞	35pF	1.5V	3.0V
LVCMOS I/O (H -> Z)	∞	106Ω	5pF	V_{OH} - 0.3	3.0V
LVCMOS I/O (L -> Z)	106Ω	∞	5pF	V_{OL} + 0.3	3.0V

1. C_L includes test fixtures and probe capacitance.

ispMACH 4000ZE Power Supply and NC Connections[1] (Cont.)

Signal	132 ucBGA[3]	144 csBGA[3]	144 TQFP[2]
VCC	M1, M7, A12, B5	H5, H8, E8, E5	36, 57, 108, 129
VCCO0 VCCO (Bank 0)	B1, H4, L2, J5, A4	E4, F4, G4, J5, D5	3, 19, 34, 47, 136
VCCO1 VCCO (Bank 1)	K9, L12, F12, D9, C7	J8, H9, G9, F9, D8	64, 75, 91, 106, 119
GND	E5, E8, H5, H8	F6, G6, G7, F7	1, 37, 73, 109
GND (Bank 0)	E2, H2, M4, B7, B3	G5, H4, H6, E6, F5	10, 18[4], 27, 46, 127, 137
GND (Bank 1)	L7, J9, H12, E9, A9	H7, J9, G8, F8, E7	55, 65, 82, 90[4], 99, 118
NC	—	**4064ZE:** E4, B2, B1, D2, D3, E1, H1, H3, H2, L1, G4, M1, K3, M2, M4, L5, H7, L8, M8, L10, K9, M11, H9, L12, L11, J12, J11, H10, D10, F10, D12, B12, F9, A12, C10, B10, A9, B8, E6, B5, A5, C4, B3, A2 **4128ZE:** D2, D3, H2, M1, K3, M11, J12, J11, D12, A12, C10, A2	**4128ZE:** 17, 20, 38, 45, 72, 89, 92, 110, 117, 144 **4256ZE:** 18, 90

1. All grounds must be electrically connected at the board level. However, for the purposes of I/O current loading, grounds are associated with the bank shown.
2. Pin orientation follows the conventional order from pin 1 marking of the top side view and counter-clockwise.
3. Pin orientation A1 starts from the upper left corner of the top side view with alphabetical order ascending vertically and numerical order ascending horizontally.
4. For the LC4256ZE, pins 18 and 90 are no connects.

ispMACH 4128ZE Logic Signal Connections: 132 ucBGA (Cont.)

Ball Number	Bank Number	GLB/MC/Pad
D10	1	G9
E12	1	G8
E9	1	GND (Bank 1)
D12	1	G6
D11	1	G5
C12	1	G4
C10	1	G2
C11	1	G1
B11	1	G0
D9	1	VCCO (Bank 1)
B12	-	TDO
A12	-	VCC
GND*	-	GND
A10	1	H14
A11	1	H13
B10	1	H12
C9	1	H10
D8	1	H9
C8	1	H8
A9	1	GND (Bank 1)
C7	1	VCCO (Bank 1)
B9	1	H6
B8	1	H5
D7	1	H4
A8	1	H2
A7	1	H1
B6	1	H0/GOE1
C6	1	CLK3/I
B7	0	GND (Bank 0)
D6	0	CLK0/I
B5	-	VCC
A6	0	A0/GOE0
C5	0	A1
B4	0	A2
A5	0	A4
C4	0	A5
D5	0	A6
A4	0	VCCO (Bank 0)
B3	0	GND (Bank 0)
D4	0	A8
A3	0	A9
C3	0	A10
B2	0	A12
C2	0	A13

ispMACH 4128ZE Logic Signal Connections: 132 ucBGA (Cont.)

Ball Number	Bank Number	GLB/MC/Pad
A2	0	A14

* All bonded core grounds are connected to the following four balls, E5, E8, H5 and H8.

ispMACH 4064ZE, 4128ZE and 4256ZE Logic Signal Connections: 144 csBGA (Cont.)

Ball Number	Bank Number	LC4064ZE	LC4128ZE	LC4256ZE
		GLB/MC/Pad	GLB/MC/Pad	GLB/MC/Pad
J4	0	B7	D12	G6
K4	0	B6	D10	G4
M3	0	B5	D9	G2
L4	0	B4	D8	G0
H6	0	GND (Bank 0)	GND (Bank 0)	GND (Bank 0)
J5	0	VCCO (Bank 0)	VCCO (Bank 0)	VCCO (Bank 0)
M4	0	NC Ball	D6	H12
L5	0	NC Ball	D5	H10
K5	0	B3	D4	H8
J6	0	B2	D2	H6
M5	0	B1	D1	H4
K6	0	B0	D0	H2
L6	0	CLK1/I	CLK1/I	CLK1/I
H7	1	NC Ball	GND (Bank 1)	GND (Bank 1)
M6	1	CLK2/I	CLK2/I	CLK2/I
H8	-	VCC	VCC	VCC
K7	1	C0	E0	I2
M7	1	C1	E1	I4
L7	1	C2	E2	I6
J7	1	C3	E4	I8
L8	1	NC Ball	E5	I10
M8	1	NC Ball	E6	I12
J8	1	VCCO (Bank 1)	VCCO (Bank 1)	VCCO (Bank 1)
J9	1	GND (Bank 1)	GND (Bank 1)	GND (Bank 1)
M9	1	C4	E8	J2
L9	1	C5	E9	J4
K8	1	C6	E10	J6
M10	1	C7	E12	J8
L10	1	NC Ball	E13	J10
K9	1	NC Ball	E14	J12
M11	1	NC Ball	NC Ball	J14
G7	-	GND	GND	GND
M12	-	TMS	TMS	TMS
H9	1	NC Ball	VCCO (Bank 1)	VCCO (Bank 1)
L12	1	NC Ball	F0	K12
L11	1	NC Ball	F1	K10
K10	1	C8	F2	K8
K12	1	C9	F4	K6
J10	1	C10	F5	K4
K11	1	C11	F6	K2
G8	1	GND (Bank 1)	GND (Bank 1)	GND (Bank 1)

ispMACH 4064ZE, 4128ZE and 4256ZE Logic Signal Connections: 144 csBGA (Cont.)

Ball Number	Bank Number	LC4064ZE	LC4128ZE	LC4256ZE
		GLB/MC/Pad	GLB/MC/Pad	GLB/MC/Pad
C7	1	CLK3/I	CLK3/I	CLK3/I
E6	0	NC Ball	GND (Bank 0)	GND (Bank 0)
A7	0	CLK0/I	CLK0/I	CLK0/I
E5	-	VCC	VCC	VCC
D6	0	A0/GOE0	A0/GOE0	A2/GOE0
B6	0	A1	A1	A4
A6	0	A2	A2	A6
C6	0	A3	A4	A8
B5	0	NC Ball	A5	A10
A5	0	NC Ball	A6	A12
D5	0	VCCO (Bank 0)	VCCO (Bank 0)	VCCO (Bank 0)
F5	0	GND (Bank 0)	GND (Bank 0)	GND (Bank 0)
A4	0	A4	A8	B2
B4	0	A5	A9	B4
C5	0	A6	A10	B6
A3	0	A7	A12	B8
C4	0	NC Ball	A13	B10
B3	0	NC Ball	A14	B12
A2	0	NC Ball	NC Ball	B14

* This pin is input only for the LC4064ZE.

ispMACH 4128ZE and 4256ZE Logic Signal Connections: 144 TQFP (Cont.)

Pin Number	Bank Number	LC4128ZE	LC4256ZE
		GLB/MC/Pad	GLB/MC/Pad
43	0	D9	G4
44	0	D8	G2
45*	0	NC	I
46	0	GND (Bank 0)	GND (Bank 0)
47	0	VCCO (Bank 0)	VCCO (Bank 0)
48	0	D6	H12
49	0	D5	H10
50	0	D4	H8
51	0	D2	H6
52	0	D1	H4
53	0	D0	H2
54	0	CLK1/I	CLK1/I
55	1	GND (Bank 1)	GND (Bank 1)
56	1	CLK2/I	CLK2/I
57	-	VCC	VCC
58	1	E0	I2
59	1	E1	I4
60	1	E2	I6
61	1	E4	I8
62	1	E5	I10
63	1	E6	I12
64	1	VCCO (Bank 1)	VCCO (Bank 1)
65	1	GND (Bank 1)	GND (Bank 1)
66	1	E8	J2
67	1	E9	J4
68	1	E10	J6
69	1	E12	J8
70	1	E13	J10
71	1	E14	J12
72*	1	NC	I
73	-	GND	GND
74	-	TMS	TMS
75	1	VCCO (Bank 1)	VCCO (Bank 1)
76	1	F0	K12
77	1	F1	K10
78	1	F2	K8
79	1	F4	K6
80	1	F5	K4
81	1	F6	K2
82	1	GND (Bank 1)	GND (Bank 1)
83	1	F8	L14
84	1	F9	L12
85	1	F10	L10

ispMACH 4128ZE and 4256ZE Logic Signal Connections: 144 TQFP (Cont.)

Pin Number	Bank Number	LC4128ZE	LC4256ZE
		GLB/MC/Pad	GLB/MC/Pad
86	1	F12	L8
87	1	F13	L6
88	1	F14	L4
89*	1	NC	I
90	1	GND (Bank 1)	NC
91	1	VCCO (Bank 1)	VCCO (Bank 1)
92*	1	NC	I
93	1	G14	M2
94	1	G13	M4
95	1	G12	M6
96	1	G10	M8
97	1	G9	M10
98	1	G8	M12
99	1	GND (Bank 1)	GND (Bank 1)
100	1	G6	N2
101	1	G5	N4
102	1	G4	N6
103	1	G2	N8
104	1	G1	N10
105	1	G0	N12
106	1	VCCO (Bank 1)	VCCO (Bank 1)
107	-	TDO	TDO
108	-	VCC	VCC
109	-	GND	GND
110*	1	NC	I
111	1	H14	O12
112	1	H13	O10
113	1	H12	O8
114	1	H10	O6
115	1	H9	O4
116	1	H8	O2
117*	1	NC	I
118	1	GND (Bank 1)	GND (Bank 1)
119	1	VCCO (Bank 1)	VCCO (Bank 1)
120	1	H6	P12
121	1	H5	P10
122	1	H4	P8
123	1	H2	P6
124	1	H1	P4
125	1	H0/GOE1	P2/GOE1
126	1	CLK3/I	CLK3/I
127	0	GND (Bank 0)	GND (Bank 0)
128	0	CLK0/I	CLK0/I

Part Number Description

LC XXXX XX – XX XX XXX X XX

Device Family

Device Number
4032 = 32 Macrocells
4064 = 64 Macrocells
4128 = 128 Macrocells
4256 = 256 Macrocells

Power
ZE = Zero Power, Enhanced

Speed
4 = 4.4ns (4032ZE Only)
4 = 4.7ns (4064ZE Only)
5 = 5.8ns (All Devices)
7 = 7.5ns (All Devices)

Production Status
Blank = Final production device
ES = Engineering samples

Operating Temperature Range
C = Commercial
I = Industrial

Pin/Ball Count
48 (1.0 mm thickness)
64
100
132
144

Package
TN = Lead-free TQFP
MN = Lead-free csBGA (0.5 mm pitch)
UMN = Lead-free ucBGA (0.4 mm pitch)

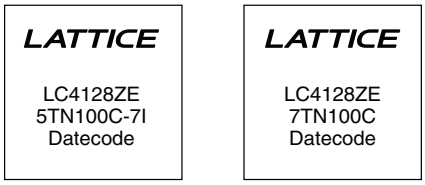
ispMACH 4000ZE Family Speed Grade Offering

	-4	-5		-7	
	Commercial	Commercial	Industrial	Commercial	Industrial
ispMACH 4032ZE	✓	✓	✓	✓	✓
ispMACH 4064ZE	✓	✓	✓	✓	✓
ispMACH 4128ZE		✓		✓	✓
ispMACH 4256ZE		✓		✓	✓

Ordering Information

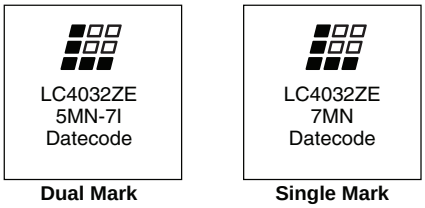
Note: ispMACH 4000ZE devices are dual marked except for the slowest commercial speed grade. For example, the commercial speed grade LC4128ZE-5TN100C is also marked with the industrial grade -7I. The commercial grade is always one speed grade faster than the associated dual mark industrial grade. The slowest commercial speed grade devices are marked as commercial grade only. The markings appear as follows:

Figure 18. Mark Format for 100 TQFP and 144 TQFP Packages



Dual Mark **Single Mark**

Figure 19. Mark Format for 48 TQFP, 64 csBGA and 144 csBGA Packages



Dual Mark **Single Mark**

Figure 20. Mark Format for 64 ucBGA and 132 ucBGA Packages

Dual Mark **Single Mark**

Lead-Free Packaging

Commercial

Device	Part Number	Macrocells	Voltage	t_{PD}	Package	Pin/Ball Count	I/O	Grade
LC4032ZE	LC4032ZE-4TN48C	32	1.8	4.4	Lead-Free TQFP	48	32	C
	LC4032ZE-5TN48C	32	1.8	5.8	Lead-Free TQFP	48	32	C
	LC4032ZE-7TN48C	32	1.8	7.5	Lead-Free TQFP	48	32	C
	LC4032ZE-4MN64C	32	1.8	4.4	Lead-Free csBGA	64	32	C
	LC4032ZE-5MN64C	32	1.8	5.8	Lead-Free csBGA	64	32	C
	LC4032ZE-7MN64C	32	1.8	7.5	Lead-Free csBGA	64	32	C
LC4064ZE	LC4064ZE-4TN48C	64	1.8	4.7	Lead-Free TQFP	48	32	C
	LC4064ZE-5TN48C	64	1.8	5.8	Lead-Free TQFP	48	32	C
	LC4064ZE-7TN48C	64	1.8	7.5	Lead-Free TQFP	48	32	C
	LC4064ZE-4TN100C	64	1.8	4.7	Lead-Free TQFP	100	64	C
	LC4064ZE-5TN100C	64	1.8	5.8	Lead-Free TQFP	100	64	C
	LC4064ZE-7TN100C	64	1.8	7.5	Lead-Free TQFP	100	64	C
	LC4064ZE-4MN64C	64	1.8	4.7	Lead-Free csBGA	64	48	C
	LC4064ZE-5MN64C	64	1.8	5.8	Lead-Free csBGA	64	48	C
	LC4064ZE-7MN64C	64	1.8	7.5	Lead-Free csBGA	64	48	C
	LC4064ZE-4MN144C	64	1.8	4.7	Lead-Free csBGA	144	64	C
	LC4064ZE-5MN144C	64	1.8	5.8	Lead-Free csBGA	144	64	C
	LC4064ZE-7MN144C	64	1.8	7.5	Lead-Free csBGA	144	64	C
LC4128ZE	LC4128ZE-5TN100C	128	1.8	5.8	Lead-Free TQFP	100	64	C
	LC4128ZE-7TN100C	128	1.8	7.5	Lead-Free TQFP	100	64	C
	LC4128ZE-5TN144C	128	1.8	5.8	Lead-Free TQFP	144	96	C
	LC4128ZE-7TN144C	128	1.8	7.5	Lead-Free TQFP	144	96	C
	LC4128ZE-5UMN132C	128	1.8	5.8	Lead-Free ucBGA	132	96	C
	LC4128ZE-7UMN132C	128	1.8	7.5	Lead-Free ucBGA	132	96	C
	LC4128ZE-5MN144C	128	1.8	5.8	Lead-Free csBGA	144	96	C
	LC4128ZE-7MN144C	128	1.8	7.5	Lead-Free csBGA	144	96	C
LC4256ZE	LC4256ZE-5TN100C	256	1.8	5.8	Lead-Free TQFP	100	64	C
	LC4256ZE-7TN100C	256	1.8	7.5	Lead-Free TQFP	100	64	C
	LC4256ZE-5TN144C	256	1.8	5.8	Lead-Free TQFP	144	96	C
	LC4256ZE-7TN144C	256	1.8	7.5	Lead-Free TQFP	144	96	C
	LC4256ZE-5MN144C	256	1.8	5.8	Lead-Free csBGA	144	108	C
	LC4256ZE-7MN144C	256	1.8	7.5	Lead-Free csBGA	144	108	C

Revision History

Date	Version	Change Summary
April 2008	01.0	Initial release.
July 2008	01.1	Updated Features bullets.
		Updated typical Hysteresis voltage.
		Updated Power Guard for Dedicated Inputs section.
		Updated DC Electrical Characteristics table.
		Updated Supply Current table.
		Updated I/O DC Electrical Characteristics table and note 2.
		Updated ispMACH 4000ZE Timing Model.
		Added new parameters for the Internal Oscillator.
		Updated ORP Reference table.
		Updated Power Supply and NC Connections table.
		Updated 100 TQFP Logic Signal Connections table with LC4128ZE and 4256ZE.
		Updated 144 csBGA Logic Signal Connections table with LC4128ZE and 4256ZE.
		Added 144 TQFP Logic Signal Connections table.
August 2008	01.2	Data sheet status changed from advance to final.
		Updated Supply Current table.
		Updated External Switching Characteristics.
		Updated Internal Timing Parameters.
		Updated Power Consumption graph and Power Estimation Coefficients table.
		Updated Ordering Information mark format example.
December 2008	01.3	Updated ispMACH 4000ZE Family Selection Guide table to include 64-ball ucBGA and 132-ball ucBGA packages.
		Updated ispMACH 4000ZE Power Supply and NC Connections table to include 64-ball ucBGA and 132-ball ucBGA packages.
		Added Logic Signal Connections tables for 64-ball ucBGA and 132-ball ucBGA packages.
		Updated Part Number Description diagram for 64-ball ucBGA and 132-ball ucBGA packages.
		Updated Ordering Information tables for 64-ball ucBGA and 132-ball ucBGA packages.
May 2009	01.4	Correction to t_{CW}, t_{GW}, t_{WIR} and f_{MAX} parameters in External Switching Characteristics table.
June 2011	01.5	Added copper bond package part numbers.
		Added footnote 4 to Absolute Maximum Ratings.
February 2012	01.6	Updated document with new corporate logo.
February 2012	01.7	Removed copper bond packaging information. Refer to PCN 04A-12 for further information.
		Updated topside marks with new logos in the Ordering Information section.